

6N137, HCNW137, HCNW2601, HCNW2611, HCPL-0600, HCPL-0601, HCPL-0611, HCPL-0630, HCPL-0631, HCPL-0661, HCPL-2601, HCPL-2611, HCPL-2630, HCPL-2631, HCPL-4661 High CMR, High Speed TTL Compatible Optocouplers



Data Sheet

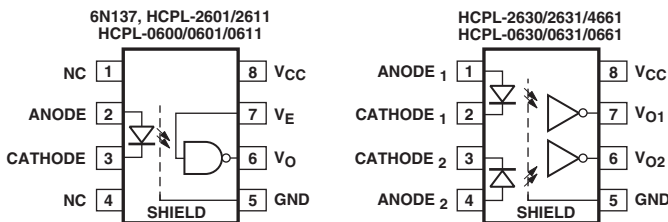


Description

The 6N137, HCPL-26XX/06XX/4661, HCNW137/26X1 are optically coupled gates that combine a GaAsP light emitting diode and an integrated high gain photo detector. An enable input allows the detector to be strobed. The output of the detector IC is an open collector Schottky-clamped transistor. The internal shield provides a guaranteed common mode transient immunity specification up to 15,000 V/μs at Vcm=1000V.

This unique design provides maximum ac and dc circuit isolation while achieving TTL compatibility. The optocoupler ac and dc operational parameters are guaranteed from -40°C to +85°C allowing troublefree system performance.

Functional Diagram



TRUTH TABLE
(POSITIVE LOGIC)

LED	ENABLE	OUTPUT
ON	H	L
OFF	H	H
ON	L	H
OFF	L	H
ON	NC	L
OFF	NC	H

TRUTH TABLE
(POSITIVE LOGIC)

LED	OUTPUT
ON	L
OFF	H

A 0.1 μF bypass capacitor must be connected between pins 5 and 8.

Features

- 15 kV/μs minimum Common Mode Rejection (CMR) at V_{CM} = 1KV for HCNW2611, HCPL-2611, HCPL-4661, HCPL-0611, HCPL-0661
- High speed: 10 MBd typical
- LSTTL/TTL compatible
- Low input current capability: 5 mA
- Guaranteed ac and dc performance over temperature: -40°C to +85°C
- Available in 8-Pin DIP, SOIC-8, widebody packages
- Storable output (single channel products only)
- Safety approval
UL recognized - 3750 V rms for 1 minute and 5000 Vrms* for 1 minute per UL1577 CSA approved IEC/EN/DIN EN 60747-5-2 approved with

$$V_{IORM} = 560 V_{peak} \text{ for 06xx Option 060}$$

$$V_{IORM} = 630 V_{peak} \text{ for 6N137/26xx Option 060}$$

$$V_{IORM} = 1414 V_{peak} \text{ for HCNW137/26X1}$$
- MIL-PRF-38534 hermetic version available (HCPL-56XX/66XX)

Applications

- Isolated line receiver
- Computer-peripheral interfaces
- Microprocessor system interfaces
- Digital isolation for A/D, D/A conversion
- Switching power supply
- Instrument input/output isolation
- Ground loop elimination
- Pulse transformer replacement
- Power transistor isolation in motor drives
- Isolation of high speed logic systems

*5000 V rms/1 Minute rating is for HCNW137/26X1 and Option 020 (6N137, HCPL-2601/11/30/31, HCPL-4661) products only.

CAUTION: It is advised that normal static precautions be taken in handling and assembly of this component to prevent damage and/or degradation which may be induced by ESD.

The 6N137, HCPL-26XX, HCPL-06XX, HCPL-4661, HCNW137, and HCNW26X1 are suitable for high speed logic interfacing, input/output buffering, as line receivers in environments that conventional line receivers cannot tolerate and are recommended for use in extremely high ground or induced noise environments.

Selection Guide

Minimum CMR		Input On-Current (mA)	Output Enable	8-Pin DIP (300 Mil)		Small-Outline SO-8		Widebody (400 Mil)	Hermetic
dV/dt (V/ μ s)	V _{CM} (V)			Single Channel Package	Dual Channel Package	Single Channel Package	Dual Channel Package	Single Channel Package	Single and Dual Channel Packages
1,000	10	5	YES	6N137					
5,000	1,000	5	YES			HCPL-0600		HCNW137	
			NO		HCPL-2630		HCPL-0630		
10,000	1,000		YES	HCPL-2601		HCPL-0601		HCNW2601	
			NO		HCPL-2631		HCPL-0631		
15,000	1,000		YES	HCPL-2611		HCPL-0611		HCNW2611	
			NO		HCPL-4661		HCPL-0661		
1,000	50		YES	HCPL-2602 ^[1]					
3,500	300		YES	HCPL-2612 ^[1]					
1,000	50	3	YES	HCPL-261A ^[1]		HCPL-061A ^[1]			
			NO		HCPL-263A ^[1]		HCPL-063A ^[1]		
1,000 ^[2]	1,000		YES	HCPL-261N ^[1]		HCPL-061N ^[1]			
			NO		HCPL-263N ^[1]		HCPL-063N ^[1]		
1,000	50	12.5	^[3]						HCPL-193X ^[1] HCPL-56XX ^[1] HCPL-66XX ^[1]

Notes:

1. Technical data are on separate Avago publications.
2. 15 kV/ μ s with V_{CM} = 1 kV can be achieved using Avago application circuit.
3. Enable is available for single channel products only, except for HCPL-193X devices.

Ordering Information

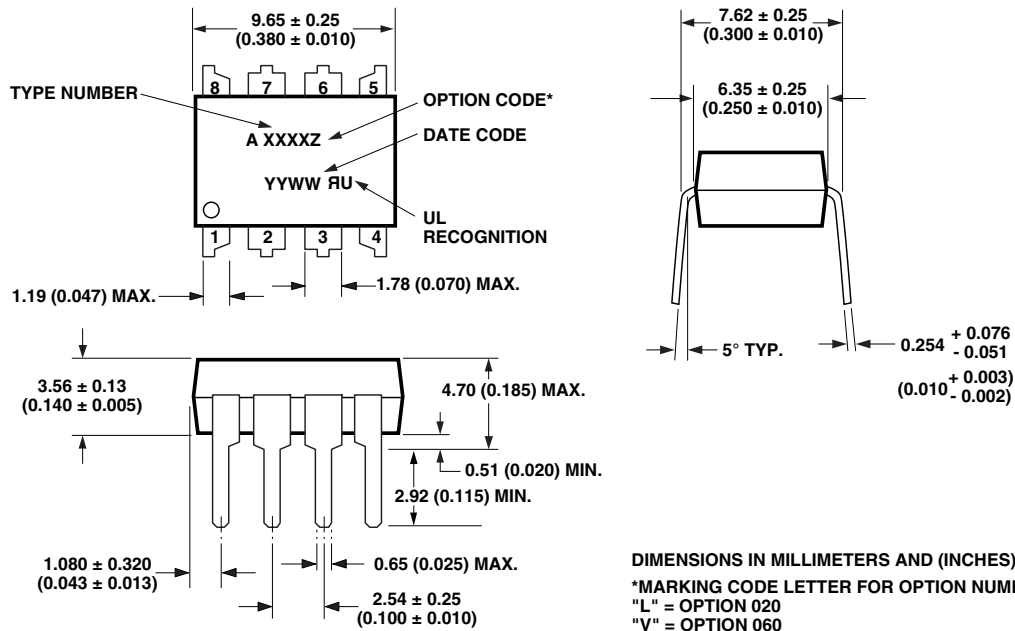
HCPL-xxxx is UL Recognized with 3750 Vrms for 1 minute per UL1577.

HCNWxxxx is UL Recognized with 5000 Vrms for 1 minute per UL1577.

Part Number	Option		Package	Surface Mount	Gull Wing	Tape & Reel	UL 5000 Vrms/ 1 Minute Rating	IEC/EN/DIN EN 60747-5-2	Quantity
	RoHS Compliant	Non RoHS Compliant							
6N137	-000E	No option	300mil DIP-8						50 per tube
	-300E	#300		X	X				50 per tube
	-500E	#500		X	X	X			1000 per reel
	-020E	#020					X		50 per tube
	-320E	#320		X	X		X		50 per tube
	-520E	#520		X	X	X	X		1000 per reel
	-060E	#060						X	50 per tube
	-560E	-560		X	X	X		X	1000 per reel
HCPL-2601	-000E	No option	300mil DIP-8						50 per tube
	-300E	#300		X	X				50 per tube
	-500E	#500		X	X	X			1000 per reel
	-020E	#020					X		50 per tube
	-320E	#320		X	X		X		50 per tube
	-520E	#520		X	X	X	X		1000 per reel
	-060E	#060						X	50 per tube
	-360E	-		X	X			X	50 per tube
HCPL-2611	-000E	No option	300mil DIP-8						50 per tube
	-300E	#300		X	X				50 per tube
	-500E	#500		X	X	X			1000 per reel
	-020E	#020					X		50 per tube
	-320E	#320		X	X		X		50 per tube
	-520E	#520		X	X	X	X		1000 per reel
	-060E	#060						X	50 per tube
	-360E	#360		X	X			X	50 per tube
HCPL-2630	-560E	#560	300mil DIP-8	X	X	X		X	1000 per reel
	-000E	No option							50 per tube
	-300E	#300		X	X				50 per tube
	-500E	#500		X	X	X			1000 per reel
	-020E	#020					X		50 per tube
	-320E	#320		X	X		X		50 per tube
HCPL-2631 HCPL-4661	-520E	-520	300mil DIP-8	X	X	X	X		1000 per reel
	-000E	No option							50 per tube
	-300E	#300		X	X				50 per tube
	-500E	#500		X	X	X			1000 per reel
	-020E	#020					X		50 per tube
	-320E	#320		X	X		X		50 per tube
	-520E	#520		X	X	X	X		1000 per reel

Package Outline Drawings

8-pin DIP Package** (6N137, HCPL-2601/11/30/31, HCPL-4661)

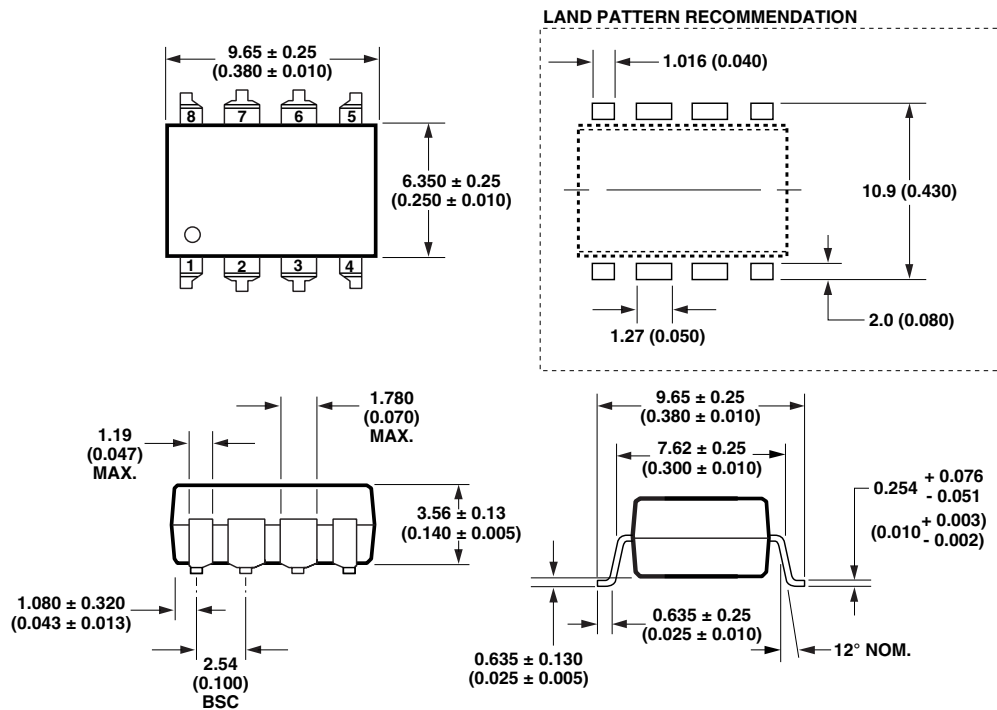


DIMENSIONS IN MILLIMETERS AND (INCHES).
 *MARKING CODE LETTER FOR OPTION NUMBERS
 "L" = OPTION 020
 "V" = OPTION 060
 OPTION NUMBERS 300 AND 500 NOT MARKED.

NOTE: FLOATING LEAD PROTRUSION IS 0.25 mm (10 mils) MAX.

**JEDEC Registered Data (for 6N137 only).

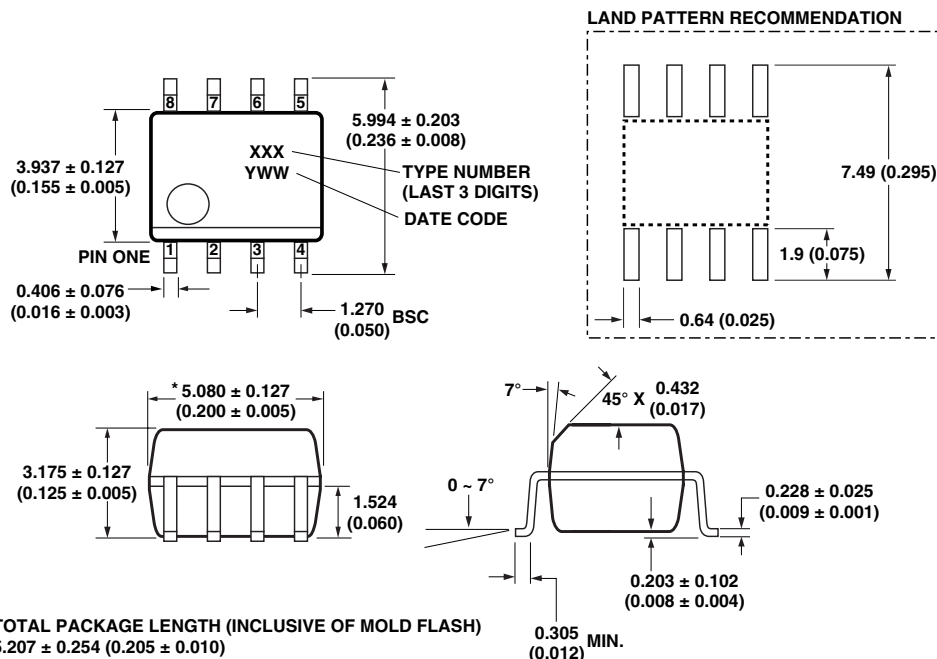
8-pin DIP Package with Gull Wing Surface Mount Option 300 (6N137, HCPL-2601/11/30/31, HCPL-4661)



DIMENSIONS IN MILLIMETERS (INCHES).
 LEAD COPLANARITY = 0.10 mm (0.004 INCHES).

NOTE: FLOATING LEAD PROTRUSION IS 0.25 mm (10 mils) MAX.

Small-Outline SO-8 Package (HCPL-0600/01/11/30/31/61)

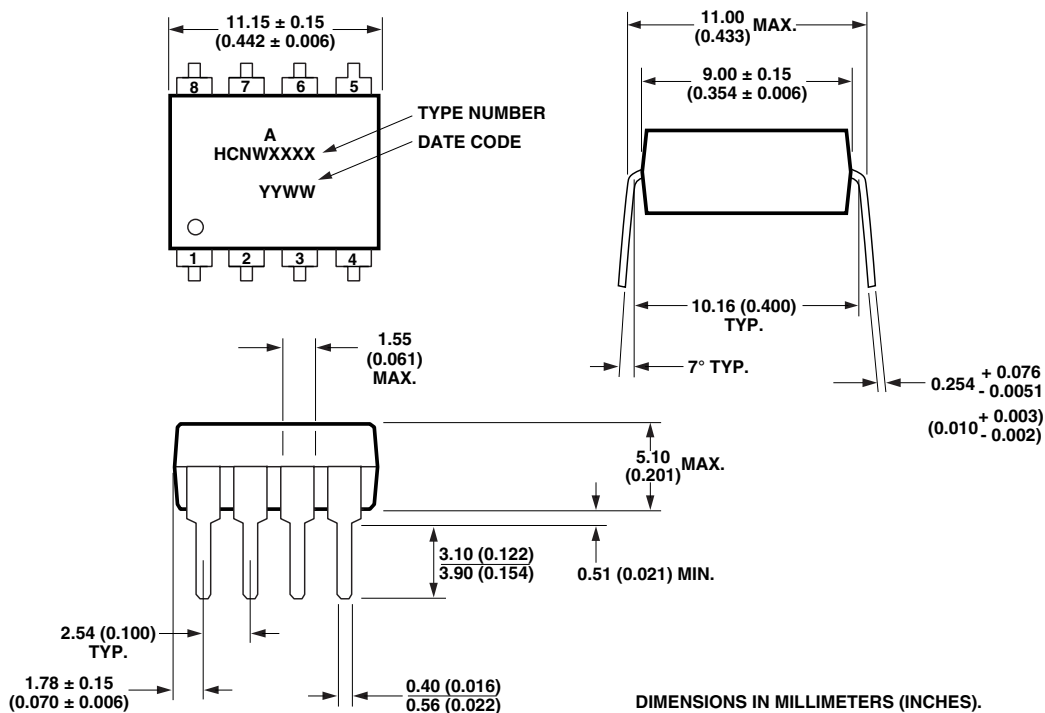


DIMENSIONS IN MILLIMETERS (INCHES).

LEAD COPLANARITY = 0.10 mm (0.004 INCHES) MAX.

NOTE: FLOATING LEAD PROTRUSION IS 0.15 mm (6 mils) MAX.

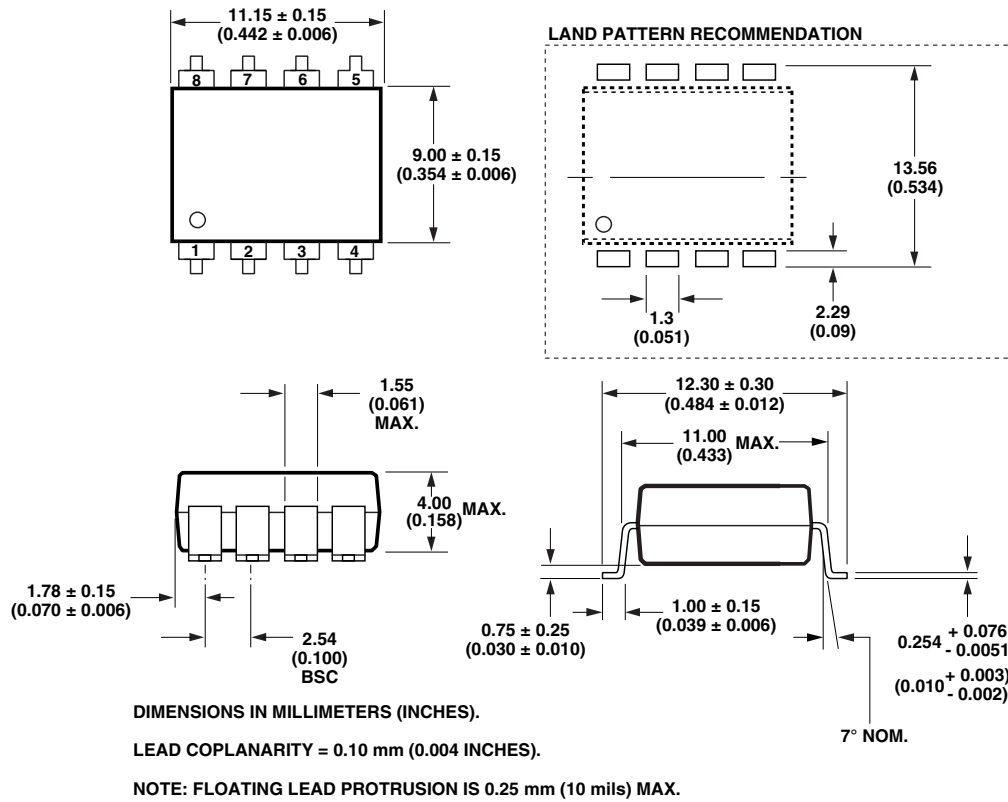
8-Pin Widebody DIP Package (HCNW137, HCNW2601/11)



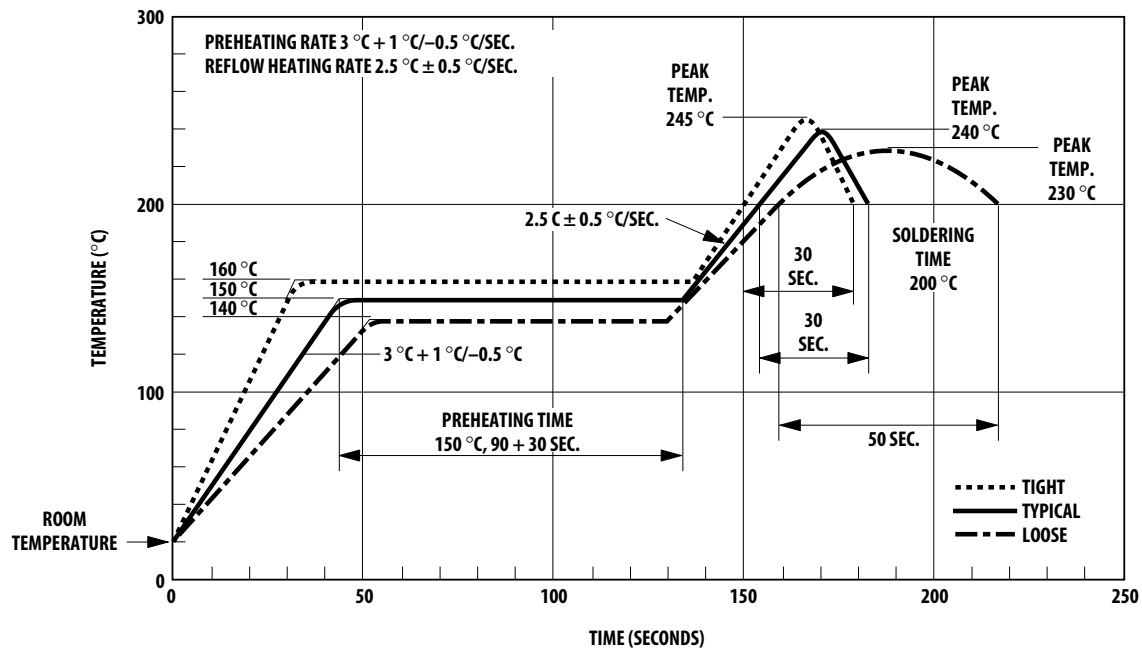
DIMENSIONS IN MILLIMETERS (INCHES).

NOTE: FLOATING LEAD PROTRUSION IS 0.25 mm (10 mils) MAX.

**8-Pin Widebody DIP Package with Gull Wing Surface Mount Option 300
(HCNW137, HCNW2601/11)**



Solder Reflow Temperature Profile



NOTE: NON-HALIDE FLUX SHOULD BE USED.

**IEC/EN/DIN EN 60747-5-2 Insulation Related Characteristics
(HCPL-06xx Option 060 Only)**

Description	Symbol	Characteristic	Units
Installation classification per DIN VDE 0110/1.89, Table 1 for rated mains voltage ≤ 150 V rms		I-IV	
for rated mains voltage ≤ 300 V rms		I-III	
for rated mains voltage ≤ 600 V rms		I-III	
Climatic Classification		55/85/21	
Pollution Degree (DIN VDE 0110/1.89)		2	
Maximum Working Insulation Voltage	V_{IORM}	567	V_{peak}
Input to Output Test Voltage, Method b* $V_{IORM} \times 1.875 = V_{PR}$, 100% Production Test with $t_m = 1$ sec, Partial Discharge < 5 pC	V_{PR}	1063	V_{peak}
Input to Output Test Voltage, Method a* $V_{IORM} \times 1.5 = V_{PR}$, Type and Sample Test, $t_m = 60$ sec, Partial Discharge < 5 pC	V_{PR}	851	V_{peak}
Highest Allowable Overvoltage (Transient Overvoltage, $t_{ini} = 10$ sec)	V_{IOTM}	6000	V_{peak}
Safety Limiting Values (Maximum values allowed in the event of a failure)			
Case Temperature	T_S	150	$^{\circ}\text{C}$
Input Current**	$I_{S,INPUT}$	150	mA
Output Power**	$P_{S,OUTPUT}$	600	mW
Insulation Resistance at T_S , $V_{IO} = 500$ V	R_S	$\geq 10^9$	Ω

*Refer to the front of the optocoupler section of the current catalog, under Product Safety Regulations section, IEC/EN/DIN EN 60747-5-2, for a detailed description.

Note: Isolation characteristics are guaranteed only within the safety maximum ratings which must be ensured by protective circuits in application.

**IEC/EN/DIN EN 60747-5-2 Insulation Related Characteristics
(HCPL-26xx; 46xx; 6N13x Option 060 Only)**

Description	Symbol	Characteristic	Units
Installation classification per DIN VDE 0110/1.89, Table 1 for rated mains voltage ≤ 300 V rms		I-IV	
for rated mains voltage ≤ 450 V rms		I-III	
Climatic Classification		55/85/21	
Pollution Degree (DIN VDE 0110/1.89)		2	
Maximum Working Insulation Voltage	V_{IORM}	630	V_{peak}
Input to Output Test Voltage, Method b* $V_{IORM} \times 1.875 = V_{PR}$, 100% Production Test with $t_m = 1$ sec, Partial Discharge < 5 pC	V_{PR}	1181	V_{peak}
Input to Output Test Voltage, Method a* $V_{IORM} \times 1.5 = V_{PR}$, Type and sample test, $t_m = 60$ sec, Partial Discharge < 5 pC	V_{PR}	945	V_{peak}
Highest Allowable Overvoltage* (Transient Overvoltage, $t_{ini} = 10$ sec)	V_{IOTM}	6000	V_{peak}
Safety Limiting Values (Maximum values allowed in the event of a failure, also see Figure 16, Thermal Derating curve.)			
Case Temperature	T_S	175	$^{\circ}\text{C}$
Input Current	$I_{S,INPUT}$	230	mA
Output Power	$P_{S,OUTPUT}$	600	mW
Insulation Resistance at T_S , $V_{IO} = 500$ V	R_S	$\geq 10^9$	Ω

*Refer to the front of the optocoupler section of the current catalog, under Product Safety Regulations section, IEC/EN/DIN EN 60747-5-2, for a detailed description.

Note: Isolation characteristics are guaranteed only within the safety maximum ratings which must be ensured by protective circuits in application.

IEC/EN/DIN EN 60747-5-2 Insulation Related Characteristics (HCNW137/2601/2611 Only)

Description	Symbol	Characteristic	Units
Installation classification per DIN VDE 0110/1.89, Table 1 for rated mains voltage ≤ 600 V rms		I-IV	
for rated mains voltage ≤ 1000 V rms		I-III	
Climatic Classification (DIN IEC 68 part 1)		55/100/21	
Pollution Degree (DIN VDE 0110/1.89)		2	
Maximum Working Insulation Voltage	V_{IORM}	1414	V_{peak}
Input to Output Test Voltage, Method b* $V_{IORM} \times 1.875 = V_{PR}$, 100% Production Test with $t_m = 1$ sec, Partial Discharge < 5 pC	V_{PR}	2651	V_{peak}
Input to Output Test Voltage, Method a* $V_{IORM} \times 1.5 = V_{PR}$, Type and sample test, $t_m = 60$ sec, Partial Discharge < 5 pC	V_{PR}	2121	V_{peak}
Highest Allowable Overvoltage* (Transient Overvoltage, $t_{ini} = 10$ sec)	V_{IOTM}	8000	V_{peak}
Safety Limiting Values (Maximum values allowed in the event of a failure, also see Figure 16, Thermal Derating curve.)			
Case Temperature	T_S	150	$^{\circ}\text{C}$
Input Current	$I_{S,INPUT}$	400	mA
Output Power	$P_{S,OUTPUT}$	700	mW
Insulation Resistance at T_S , $V_{IO} = 500$ V	R_S	$\geq 10^9$	Ω

*Refer to the front of the optocoupler section of the current catalog, under Product Safety Regulations section, IEC/EN/DIN EN 60747-5-2, for a detailed description.

Note: Isolation characteristics are guaranteed only within the safety maximum ratings which must be ensured by protective circuits in application.

Absolute Maximum Ratings* (No Derating Required up to 85°C)

Parameter	Symbol	Package**	Min.	Max.	Units	Note
Storage Temperature	T_S		-55	125	°C	
Operating Temperature†	T_A		-40	85	°C	
Average Forward Input Current	I_F	Single 8-Pin DIP Single SO-8 Widebody		20	mA	2
		Dual 8-Pin DIP Dual SO-8		15		1, 3
Reverse Input Voltage	V_R	8-Pin DIP, SO-8		5	V	1
		Widebody		3		
Input Power Dissipation	P_I	Widebody		40	mW	
Supply Voltage (1 Minute Maximum)	V_{CC}			7	V	
Enable Input Voltage (Not to Exceed V_{CC} by more than 500 mV)	V_E	Single 8-Pin DIP Single SO-8 Widebody		$V_{CC} + 0.5$	V	
Enable Input Current	I_E			5	mA	
Output Collector Current	I_O			50	mA	1
Output Collector Voltage	V_O			7	V	1
Output Collector Power Dissipation	P_O	Single 8-Pin DIP Single SO-8 Widebody		85	mW	
		Dual 8-Pin DIP Dual SO-8		60		1, 4
Lead Solder Temperature (Through Hole Parts Only)	T_{LS}	8-Pin DIP		260°C for 10 sec., 1.6 mm below seating plane		
		Widebody		260°C for 10 sec., up to seating plane		
Solder Reflow Temperature Profile (Surface Mount Parts Only)		SO-8 and Option 300		See Package Outline Drawings section		

*JEDEC Registered Data (for 6N137 only).

**Ratings apply to all devices except otherwise noted in the Package column.

†0°C to 70°C on JEDEC Registration.

Recommended Operating Conditions

Parameter	Symbol	Min.	Max.	Units
Input Current, Low Level	I_{FL}^*	0	250	μA
Input Current, High Level ^[1]	I_{FH}^{**}	5	15	mA
Power Supply Voltage	V_{CC}	4.5	5.5	V
Low Level Enable Voltage†	V_{EL}	0	0.8	V
High Level Enable Voltage†	V_{EH}	2.0	V_{CC}	V
Operating Temperature	T_A	-40	85	°C
Fan Out (at $R_L = 1\text{ k}\Omega$) ^[1]	N		5	TTL Loads
Output Pull-up Resistor	R_L	330	4 k	Ω

*The off condition can also be guaranteed by ensuring that $V_{FL} \leq 0.8$ volts.

**The initial switching threshold is 5 mA or less. It is recommended that 6.3 mA to 10 mA be used for best performance and to permit at least a 20% LED degradation guardband.

†For single channel products only.

Electrical Specifications

Over recommended temperature ($T_A = -40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$) unless otherwise specified. All Typicals at $V_{CC} = 5\text{ V}$, $T_A = 25^{\circ}\text{C}$. All enable test conditions apply to single channel products only. See note 5.

Parameter	Sym.	Package	Min.	Typ.	Max.	Units	Test Conditions	Fig.	Note
High Level Output Current	I_{OH}^*	All		5.5	100	μA	$V_{CC} = 5.5\text{ V}$, $V_E = 2.0\text{ V}$, $V_O = 5.5\text{ V}$, $I_F = 250\text{ mA}$	1	1, 6, 19
Input Threshold Current	I_{TH}	Single Channel		2.0	5.0	mA	$V_{CC} = 5.5\text{ V}$, $V_E = 2.0\text{ V}$, $V_O = 0.6\text{ V}$, $I_{OL}(\text{Sinking}) = 13\text{ mA}$	2, 3	19
		Dual Channel		2.5					
Low Level Output Voltage	V_{OL}^*	8-Pin DIP		0.35	0.6	V	$V_{CC} = 5.5\text{ V}$, $V_E = 2.0\text{ V}$, $I_F = 5\text{ mA}$, $I_{OL}(\text{Sinking}) = 13\text{ mA}$	2, 3, 4, 5	1, 19
		SO-8		0.4					
High Level Supply Current	I_{CCH}	Single Channel		7.0	10.0*	mA	$V_E = 0.5\text{ V}$ $V_{CC} = 5.5\text{ V}$ $V_E = V_{CC}$ $I_F = 0\text{ mA}$		7
		Dual Channel		10	15		Both Channels		
Low Level Supply Current	I_{CCL}	Single Channel		9.0	13.0*	mA	$V_E = 0.5\text{ V}$ $V_{CC} = 5.5\text{ V}$ $V_E = V_{CC}$ $I_F = 10\text{ mA}$		8
		Dual Channel		13	21		Both Channels		
High Level Enable Current	I_{EH}	Single Channel		-0.7	-1.6	mA	$V_{CC} = 5.5\text{ V}$, $V_E = 2.0\text{ V}$		
Low Level Enable Current	I_{EL}^*			-0.9	-1.6	mA	$V_{CC} = 5.5\text{ V}$, $V_E = 0.5\text{ V}$		9
High Level Enable Voltage	V_{EH}		2.0			V			19
Low Level Enable Voltage	V_{EL}				0.8	V			
Input Forward Voltage	V_F	8-Pin DIP	1.4	1.5	1.75*	V	$T_A = 25^{\circ}\text{C}$ $I_F = 10\text{ mA}$	6, 7	1
		SO-8	1.3		1.80				
		Widebody	1.25	1.64	1.85		$T_A = 25^{\circ}\text{C}$		
Input Reverse Breakdown Voltage	BV_R^*	8-Pin DIP	5			V	$I_R = 10\text{ }\mu\text{A}$		1
		SO-8							
		Widebody	3				$I_R = 100\text{ }\mu\text{A}$, $T_A = 25^{\circ}\text{C}$		
Input Diode Temperature Coefficient	$DV_F/\Delta T_A$	8-Pin DIP		-1.6		$\text{mV}/^{\circ}\text{C}$	$I_F = 10\text{ mA}$	7	1
		SO-8							
		Widebody		-1.9					
Input Capacitance	C_{IN}	8-Pin DIP		60		pF	$f = 1\text{ MHz}$, $V_F = 0\text{ V}$		1
		SO-8							
		Widebody		70					

*JEDEC registered data for the 6N137. The JEDEC Registration specifies 0°C to $+70^{\circ}\text{C}$. HP specifies -40°C to $+85^{\circ}\text{C}$.

Switching Specifications (AC)

Over Recommended Temperature ($T_A = -40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$), $V_{CC} = 5\text{ V}$, $I_F = 7.5\text{ mA}$ unless otherwise specified.
All Typical at $T_A = 25^{\circ}\text{C}$, $V_{CC} = 5\text{ V}$.

Parameter	Sym.	Package**	Min.	Typ.	Max.	Units	Test Conditions	Fig.	Note
Propagation Delay Time to High Output Level	t_{PLH}		20	48	75* 100	ns	$T_A = 25^{\circ}\text{C}$ $R_L = 350\ \Omega$ $C_L = 15\text{ pF}$	8, 9, 10	1, 10, 19
Propagation Delay Time to Low Output Level	t_{PHL}		25	50	75* 100	ns	$T_A = 25^{\circ}\text{C}$		1, 11, 19
Pulse Width Distortion	$ t_{PHL} - t_{PLH} $	8-Pin DIP SO-8 Widebody		3.5	35 40	ns		8, 9, 10, 11	13, 19
Propagation Delay Skew	t_{PSK}				40	ns			12, 13, 19
Output Rise Time (10-90%)	t_r			24		ns		12	1, 19
Output Fall Time (90-10%)	t_f			10		ns		12	1, 19
Propagation Delay Time of Enable from V_{EH} to V_{EL}	t_{ELH}	Single Channel		30		ns	$R_L = 350\ \Omega$, $C_L = 15\text{ pF}$, $V_{EL} = 0\text{ V}$, $V_{EH} = 3\text{ V}$	13, 14	14
Propagation Delay Time of Enable from V_{EL} to V_{EH}	t_{EHL}	Single Channel		20		ns			15

*JEDEC registered data for the 6N137.

**Ratings apply to all devices except otherwise noted in the Package column.

Parameter	Sym.	Device	Min.	Typ.	Units	Test Conditions		Fig.	Note
Logic High Common Mode Transient Immunity	$ CM_H $	6N137	1,000	10,000	V/ μ s	$ V_{CM} = 10\text{ V}$	$V_{CC} = 5\text{ V}$, $I_F = 0\text{ mA}$, $V_{O(MIN)} = 2\text{ V}$, $R_L = 350\ \Omega$, $T_A = 25^\circ\text{C}$	15	1, 16, 18, 19
		HCPL-2630	5,000	10,000		$ V_{CM} = 1\text{ kV}$			
		HCPL-0600/0630							
		HCNW137							
		HCPL-2601/2631	10,000	15,000		$ V_{CM} = 1\text{ kV}$			
		HCPL-0601/0631							
		HCNW2601							
		HCPL-2611/4661	15,000	25,000		$ V_{CM} = 1\text{ kV}$			
		HCPL-0611/0661							
HCNW2611									
Logic Low Common Mode Transient Immunity	$ CM_L $	6N137	1,000	10,000	V/ μ s	$ V_{CM} = 10\text{ V}$	$V_{CC} = 5\text{ V}$, $I_F = 7.5\text{ mA}$, $V_{O(MAX)} = 0.8\text{ V}$, $R_L = 350\ \Omega$, $T_A = 25^\circ\text{C}$	15	1, 17, 18, 19
		HCPL-2630	5,000	10,000		$ V_{CM} = 1\text{ kV}$			
		HCPL-0600/0630							
		HCNW137							
		HCPL-2601/2631	10,000	15,000		$ V_{CM} = 1\text{ kV}$			
		HCPL-0601/0631							
		HCNW2601							
		HCPL-2611/4661	15,000	25,000		$ V_{CM} = 1\text{ kV}$			
		HCPL-0611/0661							
HCNW2611									

Package Characteristics

All Typicals at $T_A = 25^\circ\text{C}$.

Parameter	Sym.	Package	Min.	Typ.	Max.	Units	Test Conditions	Fig.	Note
Input-Output Insulation	I_{I-O}^*	Single 8-Pin DIP Single SO-8			1	μA	45% RH, $t = 5\text{ s}$, $V_{I-O} = 3\text{ kV dc}$, $T_A = 25^\circ\text{C}$		20, 21
Input-Output Momentary Withstand Voltage**	V_{ISO}	8-Pin DIP, SO-8 Widebody OPT 020†	3750 5000 5000			V rms	RH $\leq 50\%$, $t = 1\text{ min}$, $T_A = 25^\circ\text{C}$		20, 21 20, 22
Input-Output Resistance	R_{I-O}	8-Pin DIP, SO-8 Widebody	10^{12} 10^{12} 10^{11}	10^{13}		Ω	$V_{I-O} = 500\text{ V dc}$ $T_A = 25^\circ\text{C}$ $T_A = 100^\circ\text{C}$		1, 20, 23
Input-Output Capacitance	C_{I-O}	8-Pin DIP, SO-8 Widebody	0.6 0.5	0.6		pF	$f = 1\text{ MHz}$, $T_A = 25^\circ\text{C}$		1, 20, 23
Input-Input Insulation Leakage Current	I_{I-I}	Dual Channel		0.005		μA	RH $\leq 45\%$, $t = 5\text{ s}$, $V_{I-I} = 500\text{ V}$		24
Resistance (Input-Input)	R_{I-I}	Dual Channel		10^{11}		Ω			24
Capacitance (Input-Input)	C_{I-I}	Dual 8-Pin DIP Dual SO-8		0.03 0.25		pF	$f = 1\text{ MHz}$		24

*JEDEC registered data for the 6N137. The JEDEC Registration specifies 0°C to 70°C . Avago specifies -40°C to 85°C .

**The Input-Output Momentary Withstand Voltage is a dielectric voltage rating that should not be interpreted as an input-output continuous voltage rating. For the continuous voltage rating refer to the IEC/EN/DIN EN 60747-5-2 Insulation Characteristics Table (if applicable), your equipment level safety specification or Avago Application Note 1074 entitled "Optocoupler Input-Output Endurance Voltage."

†For 6N137, HCPL-2601/2611/2630/2631/4661 only.

Notes:

- Each channel.
- Peaking circuits may produce transient input currents up to 50 mA, 50 ns maximum pulse width, provided average current does not exceed 20 mA.
- Peaking circuits may produce transient input currents up to 50 mA, 50 ns maximum pulse width, provided average current does not exceed 15 mA.
- Derate linearly above 80°C free-air temperature at a rate of $2.7\text{ mW}/^\circ\text{C}$ for the SOIC-8 package.
- Bypassing of the power supply line is required, with a $0.1\text{ }\mu\text{F}$ ceramic disc capacitor adjacent to each optocoupler as illustrated in Figure 17. Total lead length between both ends of the capacitor and the isolator pins should not exceed 20 mm.
- The JEDEC registration for the 6N137 specifies a maximum I_{OH} of 250 μA . Avago guarantees a maximum I_{OH} of 100 μA .
- The JEDEC registration for the 6N137 specifies a maximum I_{CCH} of 15 mA. Avago guarantees a maximum I_{CCH} of 10 mA.
- The JEDEC registration for the 6N137 specifies a maximum I_{CCL} of 18 mA. Avago guarantees a maximum I_{CCL} of 13 mA.
- The JEDEC registration for the 6N137 specifies a maximum I_{EL} of -2.0 mA . Avago guarantees a maximum I_{EL} of -1.6 mA .
- The t_{PLH} propagation delay is measured from the 3.75 mA point on the falling edge of the input pulse to the 1.5 V point on the rising edge of the output pulse.
- The t_{PHL} propagation delay is measured from the 3.75 mA point on the rising edge of the input pulse to the 1.5 V point on the falling edge of the output pulse.
- t_{PSK} is equal to the worst case difference in t_{PHL} and/or t_{PLH} that will be seen between units at any given temperature and specified test conditions.
- See application section titled "Propagation Delay, Pulse-Width Distortion and Propagation Delay Skew" for more information.
- The t_{ELH} enable propagation delay is measured from the 1.5 V point on the falling edge of the enable input pulse to the 1.5 V point on the rising edge of the output pulse.
- The t_{EHL} enable propagation delay is measured from the 1.5 V point on the rising edge of the enable input pulse to the 1.5 V point on the falling edge of the output pulse.
- CM_{tr} is the maximum tolerable rate of rise of the common mode voltage to assure that the output will remain in a high logic state (i.e., $V_o > 2.0\text{ V}$).
- CM_L is the maximum tolerable rate of fall of the common mode voltage to assure that the output will remain in a low logic state (i.e., $V_o < 0.8\text{ V}$).
- For sinusoidal voltages, $(dV_{CM}/dt)_{max} = \pi f_{CM} V_{CM}(p-p)$.
- No external pull up is required for a high logic state on the enable input. If the V_E pin is not used, tying V_E to V_{CC} will result in improved CMR performance. For single channel products only.
- Device considered a two-terminal device: pins 1, 2, 3, and 4 shorted together, and pins 5, 6, 7, and 8 shorted together.
- In accordance with UL 1577, each optocoupler is proof tested by applying an insulation test voltage $\geq 4500\text{ V rms}$ for one second (leakage detection current limit, $I_{I-O} \leq 5\text{ }\mu\text{A}$). This test is performed before the 100% production test for partial discharge (Method b) shown in the IEC/EN/DIN EN 60747-5-2 Insulation Characteristics Table, if applicable.
- In accordance with UL 1577, each optocoupler is proof tested by applying an insulation test voltage $\geq 6000\text{ V rms}$ for one second (leakage detection current limit, $I_{I-O} \leq 5\text{ }\mu\text{A}$). This test is performed before the 100% production test for partial discharge (Method b) shown in the IEC/EN/DIN EN 60747-5-2 Insulation Characteristics Table, if applicable.
- Measured between the LED anode and cathode shorted together and pins 5 through 8 shorted together. For dual channel products only.
- Measured between pins 1 and 2 shorted together, and pins 3 and 4 shorted together. For dual channel products only.

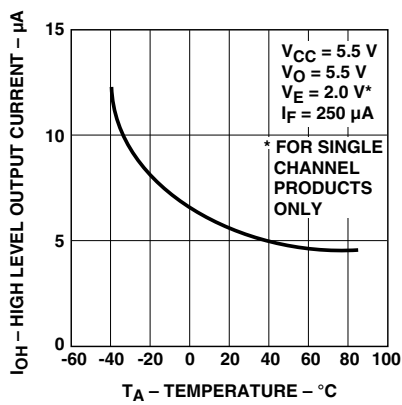


Figure 1. Typical high level output current vs. temperature.

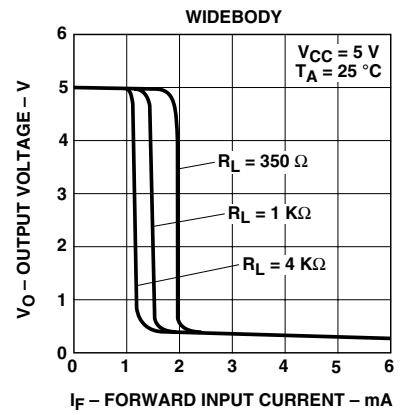
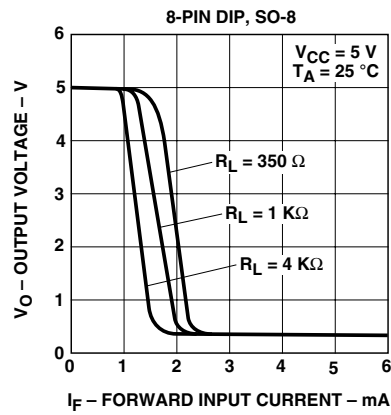


Figure 2. Typical output voltage vs. forward input current.

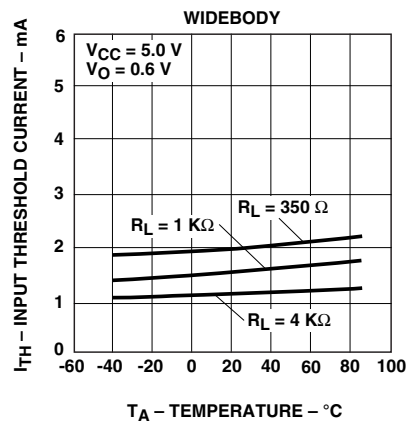
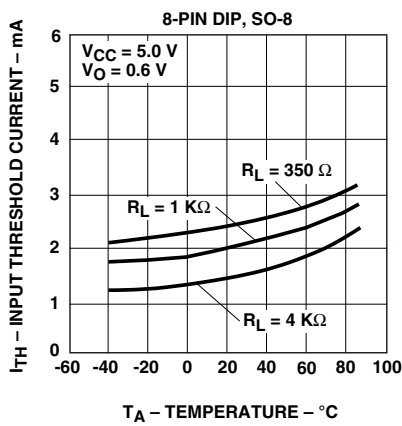


Figure 3. Typical input threshold current vs. temperature.

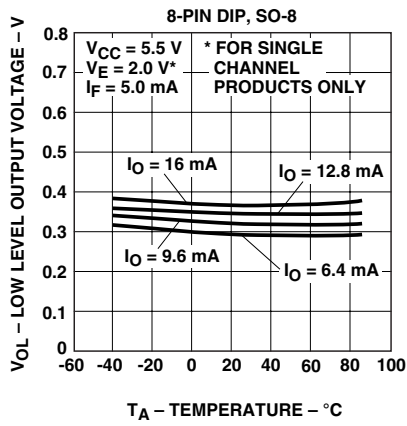


Figure 4. Typical low level output voltage vs. temperature.

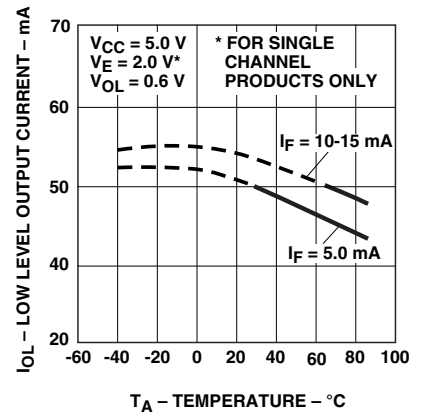
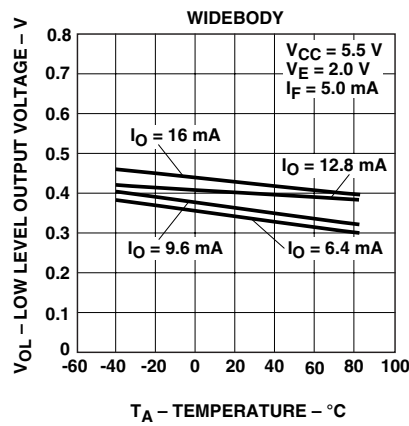


Figure 5. Typical low level output current vs. temperature.

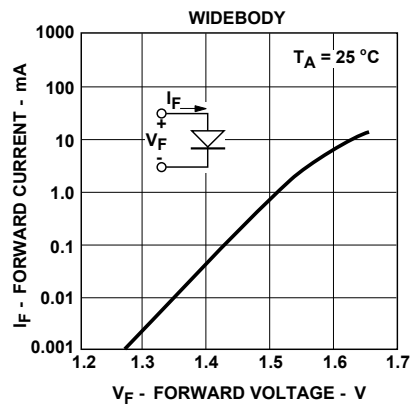
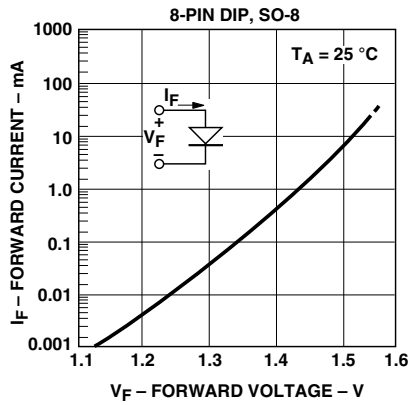


Figure 6. Typical input diode forward characteristic.

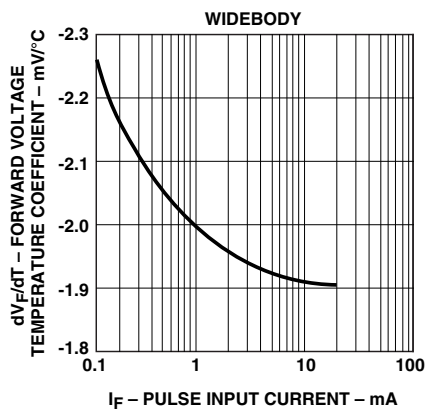
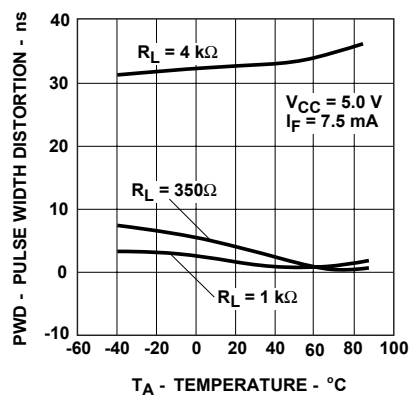
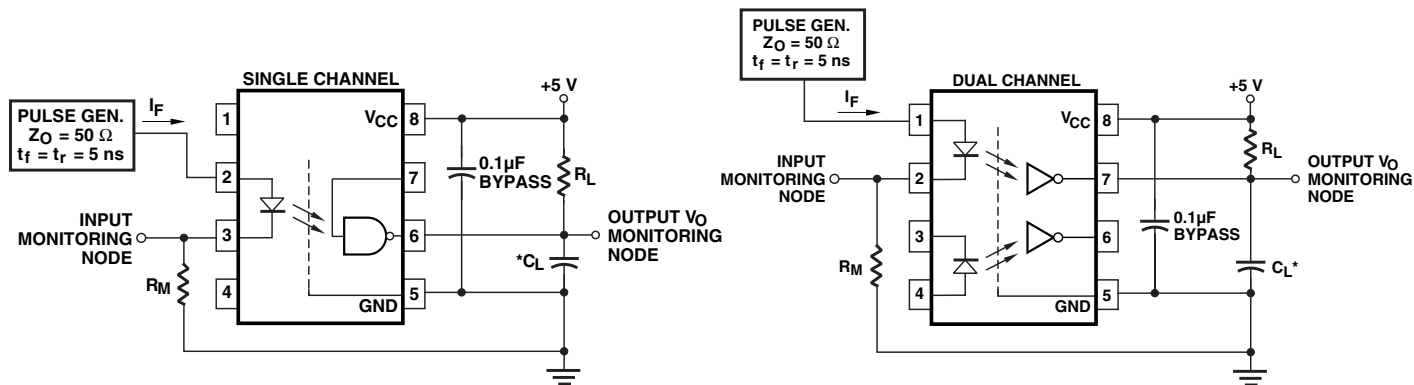


Figure 7. Typical temperature coefficient of forward voltage vs. input current.



*C_L IS APPROXIMATELY 15 pF WHICH INCLUDES PROBE AND STRAY WIRING CAPACITANCE.

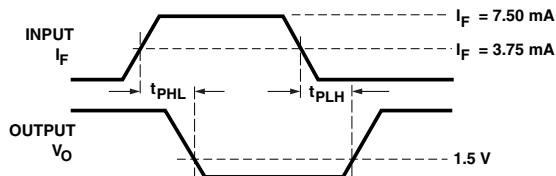


Figure 8. Test circuit for t_{PHL} and t_{PLH} .

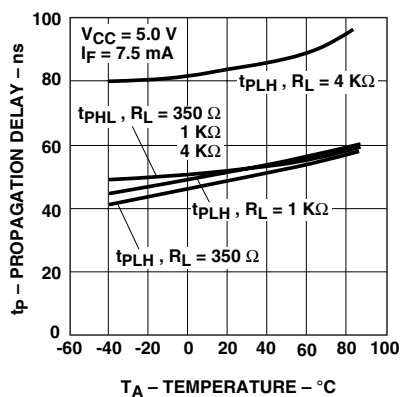


Figure 9. Typical propagation delay vs. temperature.

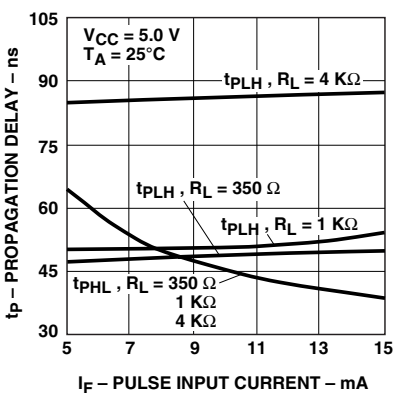


Figure 10. Typical propagation delay vs. pulse input current.

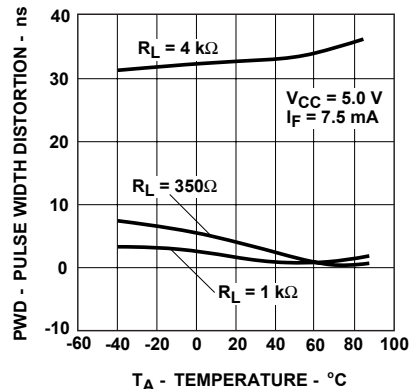


Figure 11. Typical pulse width distortion vs. temperature.

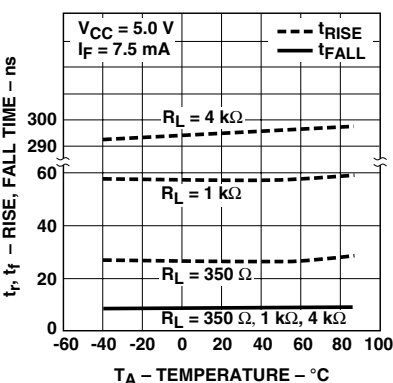
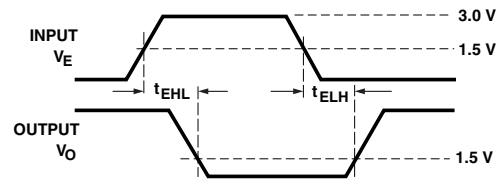
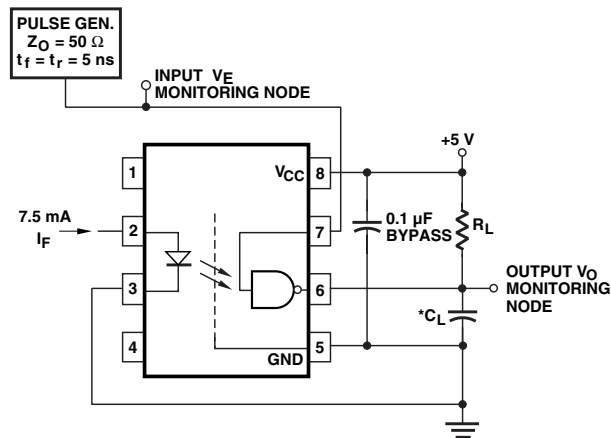


Figure 12. Typical rise and fall time vs. temperature.



* C_L IS APPROXIMATELY 15 pF WHICH INCLUDES PROBE AND STRAY WIRING CAPACITANCE.

Figure 13. Test circuit for t_{EHL} and t_{ELH} .

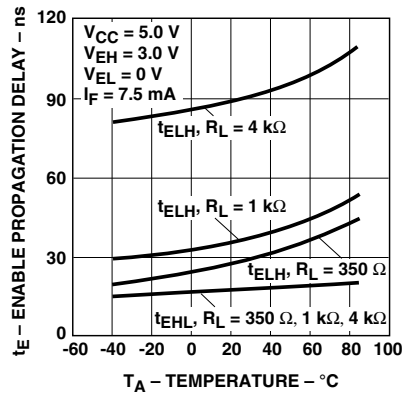


Figure 14. Typical enable propagation delay vs. temperature.

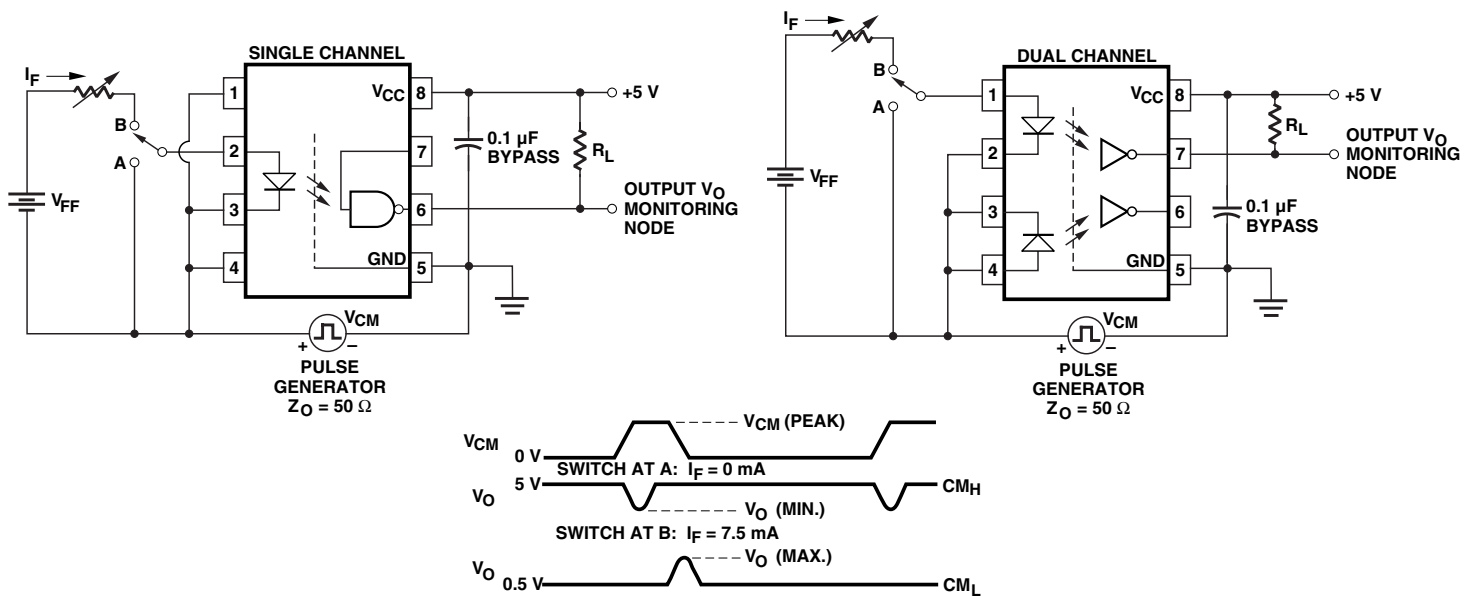


Figure 15. Test circuit for common mode transient immunity and typical waveforms.

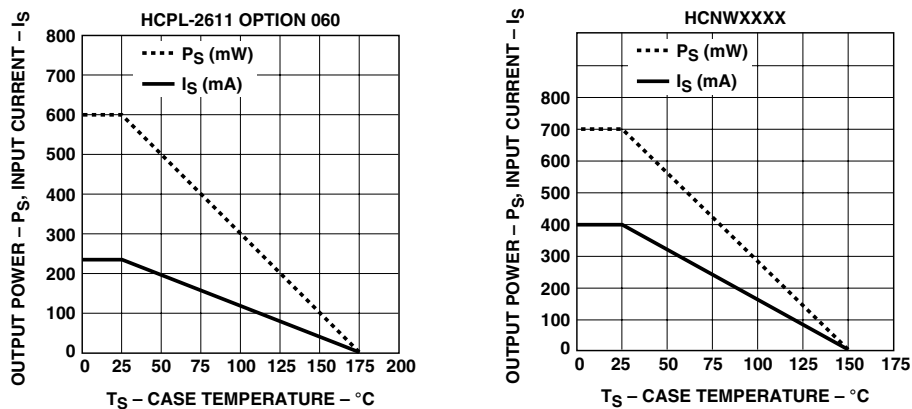


Figure 16. Thermal derating curve, dependence of safety limiting value with case temperature per IEC/EN/DIN EN 60747-5-2.

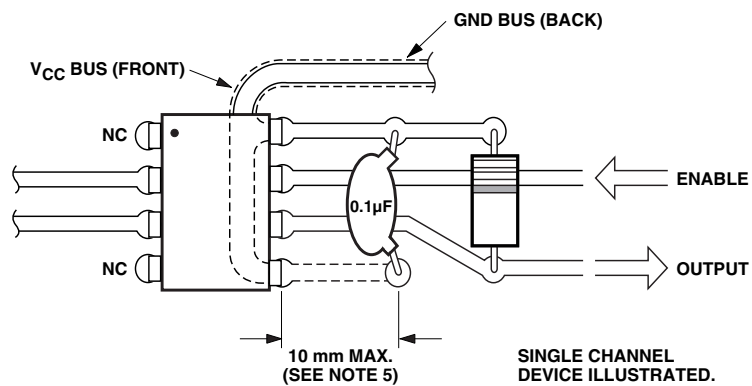


Figure 17. Recommended printed circuit board layout.



Propagation Delay, Pulse-Width Distortion and Propagation Delay Skew

Propagation delay is a figure of merit which describes how quickly a logic signal propagates through a system. The propagation delay from low to high (t_{PLH}) is the amount of time required for an input signal to propagate to the output, causing the output to change from low to high. Similarly, the propagation delay from high to low (t_{PHL}) is the amount of time required for the input signal to propagate to the output causing the output to change from high to low (see Figure 8).

Pulse-width distortion (PWD) results when t_{PLH} and t_{PHL} differ in value. PWD is defined as the difference between t_{PLH} and t_{PHL} and often determines the maximum data rate capability of a transmission system. PWD can be expressed in percent by dividing the PWD (in ns) by the minimum pulse width (in ns) being transmitted. Typically, PWD on the order of 20-30% of the minimum pulse width is tolerable; the exact figure depends on the particular application (RS232, RS422, T-1, etc.).

Propagation delay skew, t_{PSK} , is an important parameter to consider in parallel data applications where synchronization of signals on parallel data lines is a concern. If the parallel data is being sent through a group of optocouplers, differences in propagation delays will cause the data to arrive at the outputs of the optocouplers at different times. If this difference in propagation delays is large enough, it will determine the maximum rate at which parallel data can be sent through the optocouplers.

Propagation delay skew is defined as the difference between the minimum and maximum propagation delays, either t_{PLH} or t_{PHL} for any given group of optocouplers which are operating under the same conditions (i.e., the same drive current, supply voltage, output load, and operating temperature). As illustrated in Figure 19, if the in-

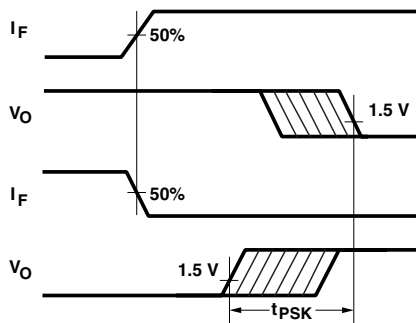


Figure 19. Illustration of propagation delay skew - t_{PSK} .

puts of a group of optocouplers are switched either ON or OFF at the same time, t_{PSK} is the difference between the shortest propagation delay, either t_{PLH} or t_{PHL} , and the longest propagation delay, either t_{PLH} or t_{PHL} .

As mentioned earlier, t_{PSK} can determine the maximum parallel data transmission rate. Figure 20 is the timing diagram of a typical parallel data application with both the clock and the data lines being sent through optocouplers. The figure shows data and clock signals at the inputs and outputs of the optocouplers. To obtain the maximum data transmission rate, both edges of the clock signal are being used to clock the data; if only one edge were used, the clock signal would need to be twice as fast.

Propagation delay skew represents the uncertainty of where an edge might be after being sent through an optocoupler. Figure 20 shows that there will be uncertainty in both the data and the clock lines. It is important that these two areas of uncertainty not overlap, otherwise the clock signal might arrive before all of the data outputs have settled, or some of the data outputs may start to change before the clock signal has arrived. From these considerations, the absolute minimum pulse width that can be sent through optocouplers in a parallel application is twice t_{PSK} . A cautious design should use a slightly longer pulse width to ensure that any additional uncertainty in the rest of the circuit does not cause a problem.

The t_{PSK} specified optocouplers offer the advantages of guaranteed specifications for propagation delays, pulse-width distortion and propagation delay skew over the recommended temperature, input current, and power supply ranges.

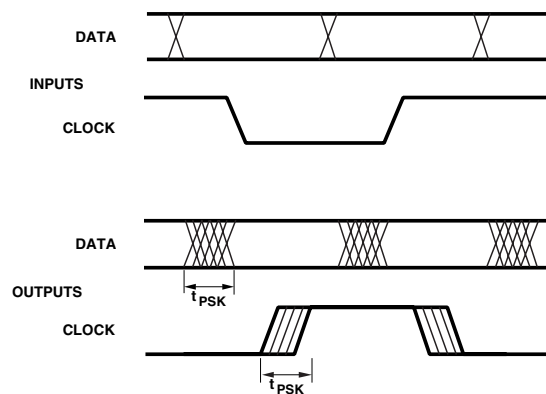


Figure 20. Parallel data transmission example.

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AV02-0940EN - June 20, 2008

